## Notice of References Cited Application/Control No. 10/575,595 Examiner Ron Schwadron, Ph.D. Applicant(s)/Patent Under Reexamination LI, SAU WEI Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,987,084	01-1991	Tedder et al.	436/63
*	В	US-2003/0092646	05-2003	Blatt et al.	514/44
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			V		
	0					
L	Р					
	Q					
	R					
	S.			1		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	W	
	x	s reference in not being furnished with this Office and the Co. NOTE 2 TO THE STATE OF THE STATE

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

**Notice of References Cited** 

Part of Paper No. 200709

9/26/57